

## 207.1 - Scanning Electron Microscope (SEM)

This RM is intended for calibrating the magnification scale and evaluating the performance of scanning electron microscopes.

PLEASE NOTE: The tables are presented to facilitate comparisons among a family of materials to help customers select the best SRM for their needs. For specific values and uncertainties, the certificate is the only official source.

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<b>SRM</b>	<b>Description</b>	<b>Unit Size</b>
8820	Scanning Electron Microscope Scale Calibration Artifact	each

- Certified values are normal font
- Reference values are italicized
- Values in parentheses are for information only